



Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from,Europe,America and south Asia,supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of “Quality Parts,Customers Priority,Honest Operation,and Considerate Service”,our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip,ALPS,ROHM,Xilinx,Pulse,ON,Everlight and Freescale. Main products comprise IC,Modules,Potentiometer,IC Socket,Relay,Connector.Our parts cover such applications as commercial,industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832

Email & Skype: info@chipsmall.com Web: www.chipsmall.com

Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China



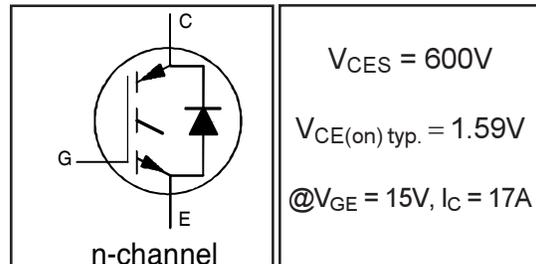
IRG4BC30FDPbF

INSULATED GATE BIPOLAR TRANSISTOR WITH ULTRAFAST
 SOFT RECOVERY DIODE

Fast CoPack IGBT

Features

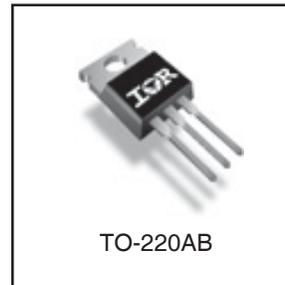
- Fast: Optimized for medium operating frequencies (1-5 kHz in hard switching, >20kHz in resonant mode).
- Generation 4 IGBT design provides tighter parameter distribution and higher efficiency than Generation 3
- IGBT co-packaged with HEXFRED™ ultrafast, ultra-soft-recovery anti-parallel diodes for use in bridge configurations
- Industry standard TO-220AB package
- Lead-Free



$V_{CES} = 600V$
 $V_{CE(on) typ.} = 1.59V$
 @ $V_{GE} = 15V, I_C = 17A$

Benefits

- Generation -4 IGBT's offer highest efficiencies available
- IGBT's optimized for specific application conditions
- HEXFRED diodes optimized for performance with IGBT's. Minimized recovery characteristics require less/no snubbing
- Designed to be a "drop-in" replacement for equivalent industry-standard Generation 3 IR IGBT's



Absolute Maximum Ratings

| | Parameter | Max. | Units |
|---------------------------|---|---------------------|------------|
| V_{CES} | Collector-to-Emitter Voltage | 600 | V |
| $I_C @ T_C = 25^\circ C$ | Continuous Collector Current | 31 | A |
| $I_C @ T_C = 100^\circ C$ | Continuous Collector Current | 17 | |
| I_{CM} | Pulsed Collector Current ① | 124 | |
| I_{LM} | Clamped Inductive Load Current ② | 124 | |
| $I_F @ T_C = 100^\circ C$ | Diode Continuous Forward Current | 12 | |
| I_{FM} | Diode Maximum Forward Current | 120 | |
| V_{GE} | Gate-to-Emitter Voltage | ± 20 | V |
| $P_D @ T_C = 25^\circ C$ | Maximum Power Dissipation | 100 | W |
| $P_D @ T_C = 100^\circ C$ | Maximum Power Dissipation | 42 | |
| T_J | Operating Junction and Storage Temperature Range | -55 to +150 | $^\circ C$ |
| T_{STG} | | | |
| | | | |
| | Mounting Torque, 6-32 or M3 Screw. | 10 lbf•in (1.1 N•m) | |

Thermal Resistance

| | Parameter | Min. | Typ. | Max. | Units |
|-----------------|---|-------|----------|-------|--------------|
| $R_{\theta JC}$ | Junction-to-Case - IGBT | ----- | ----- | 1.2 | $^\circ C/W$ |
| $R_{\theta JC}$ | Junction-to-Case - Diode | ----- | ----- | 2.5 | |
| $R_{\theta CS}$ | Case-to-Sink, flat, greased surface | ----- | 0.50 | ----- | |
| $R_{\theta JA}$ | Junction-to-Ambient, typical socket mount | ----- | ----- | 80 | |
| Wt | Weight | ----- | 2 (0.07) | ----- | g (oz) |

IRG4BC30FDPbF

Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

| | Parameter | Min. | Typ. | Max. | Units | Conditions |
|--|---|------|------|------|-------|--|
| V _{(BR)CES} | Collector-to-Emitter Breakdown Voltage ^③ | 600 | ---- | ---- | V | V _{GE} = 0V, I _C = 250μA |
| ΔV _{(BR)CES} /ΔT _J | Temperature Coeff. of Breakdown Voltage | ---- | 0.69 | ---- | V/°C | V _{GE} = 0V, I _C = 1.0mA |
| V _{CE(on)} | Collector-to-Emitter Saturation Voltage | ---- | 1.59 | 1.8 | V | I _C = 17A V _{GE} = 15V |
| | | ---- | 1.99 | ---- | | I _C = 31A See Fig. 2, 5 |
| | | ---- | 1.70 | ---- | | I _C = 17A, T _J = 150°C |
| V _{GE(th)} | Gate Threshold Voltage | 3.0 | ---- | 6.0 | | V _{CE} = V _{GE} , I _C = 250μA |
| ΔV _{GE(th)} /ΔT _J | Temperature Coeff. of Threshold Voltage | ---- | -11 | ---- | mV/°C | V _{CE} = V _{GE} , I _C = 250μA |
| g _{fe} | Forward Transconductance ^④ | 6.1 | 10 | ---- | S | V _{CE} = 100V, I _C = 17A |
| I _{CES} | Zero Gate Voltage Collector Current | ---- | ---- | 250 | μA | V _{GE} = 0V, V _{CE} = 600V |
| | | ---- | ---- | 2500 | | V _{GE} = 0V, V _{CE} = 600V, T _J = 150°C |
| V _{FM} | Diode Forward Voltage Drop | ---- | 1.4 | 1.7 | V | I _C = 12A See Fig. 13 |
| | | ---- | 1.3 | 1.6 | | I _C = 12A, T _J = 150°C |
| I _{GES} | Gate-to-Emitter Leakage Current | ---- | ---- | ±100 | nA | V _{GE} = ±20V |

Switching Characteristics @ T_J = 25°C (unless otherwise specified)

| | Parameter | Min. | Typ. | Max. | Units | Conditions | |
|--------------------------|---|------|------|------|-------|--|--|
| Q _g | Total Gate Charge (turn-on) | ---- | 51 | 77 | nC | I _C = 17A | |
| Q _{ge} | Gate - Emitter Charge (turn-on) | ---- | 7.9 | 12 | | V _{CC} = 400V See Fig. 8 | |
| Q _{gc} | Gate - Collector Charge (turn-on) | ---- | 19 | 28 | | V _{GE} = 15V | |
| t _{d(on)} | Turn-On Delay Time | ---- | 42 | ---- | ns | T _J = 25°C | |
| t _r | Rise Time | ---- | 26 | ---- | | I _C = 17A, V _{CC} = 480V | |
| t _{d(off)} | Turn-Off Delay Time | ---- | 230 | 350 | | V _{GE} = 15V, R _G = 23Ω | |
| t _f | Fall Time | ---- | 160 | 230 | mJ | Energy losses include "tail" and diode reverse recovery. | |
| E _{on} | Turn-On Switching Loss | ---- | 0.63 | ---- | | See Fig. 9, 10, 11, 18 | |
| E _{off} | Turn-Off Switching Loss | ---- | 1.39 | ---- | | | |
| E _{ts} | Total Switching Loss | ---- | 2.02 | 3.9 | mJ | T _J = 150°C, See Fig. 9, 10, 11, 18 | |
| t _{d(on)} | Turn-On Delay Time | ---- | 42 | ---- | | | I _C = 17A, V _{CC} = 480V |
| t _r | Rise Time | ---- | 27 | ---- | | | V _{GE} = 15V, R _G = 23Ω |
| t _{d(off)} | Turn-Off Delay Time | ---- | 310 | ---- | mJ | Energy losses include "tail" and diode reverse recovery. | |
| t _f | Fall Time | ---- | 310 | ---- | | | |
| E _{ts} | Total Switching Loss | ---- | 3.2 | ---- | | | |
| L _E | Internal Emitter Inductance | ---- | 7.5 | ---- | nH | Measured 5mm from package | |
| C _{ies} | Input Capacitance | ---- | 1100 | ---- | pF | V _{GE} = 0V | |
| C _{oes} | Output Capacitance | ---- | 74 | ---- | | V _{CC} = 30V See Fig. 7 | |
| C _{res} | Reverse Transfer Capacitance | ---- | 14 | ---- | | f = 1.0MHz | |
| t _{rr} | Diode Reverse Recovery Time | ---- | 42 | 60 | ns | T _J = 25°C See Fig. 14 | |
| | | ---- | 80 | 120 | | T _J = 125°C | |
| I _{rr} | Diode Peak Reverse Recovery Current | ---- | 3.5 | 6.0 | A | T _J = 25°C See Fig. 15 | |
| | | ---- | 5.6 | 10 | | T _J = 125°C | |
| Q _{rr} | Diode Reverse Recovery Charge | ---- | 80 | 180 | nC | T _J = 25°C See Fig. 16 | |
| | | ---- | 220 | 600 | | T _J = 125°C | |
| di _(rec) M/dt | Diode Peak Rate of Fall of Recovery During t _b | ---- | 180 | ---- | A/μs | T _J = 25°C See Fig. 17 | |
| | | ---- | 120 | ---- | | T _J = 125°C | |

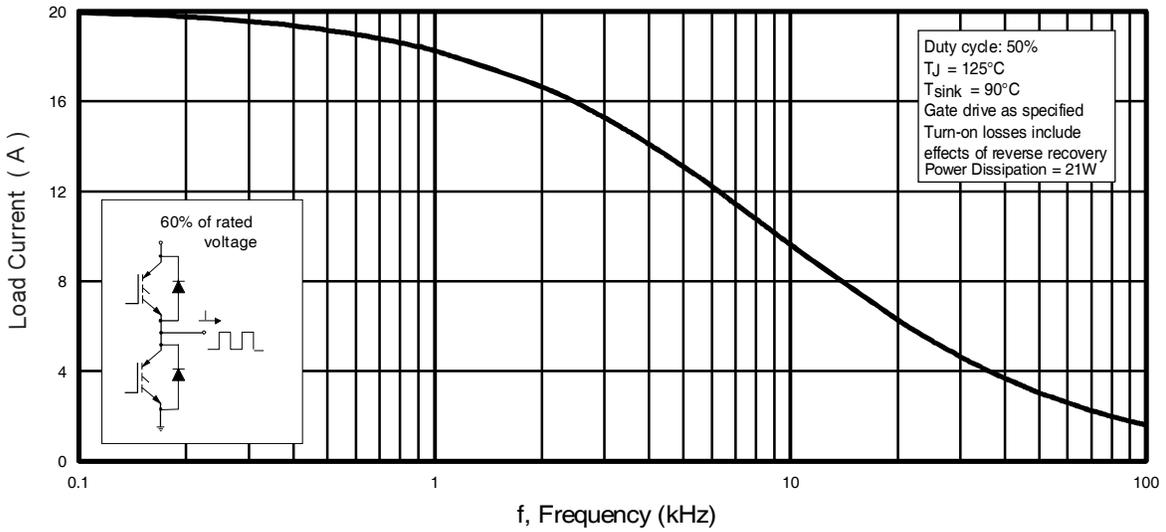


Fig. 1 - Typical Load Current vs. Frequency
 (Load Current = I_{RMS} of fundamental)

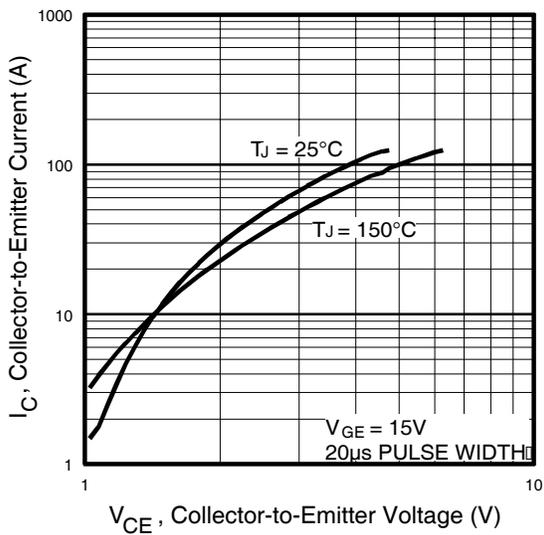


Fig. 2 - Typical Output Characteristics

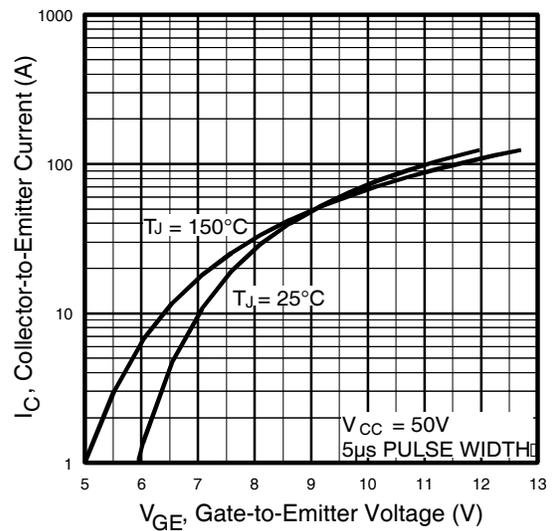


Fig. 3 - Typical Transfer Characteristics

IRG4BC30FDPbF

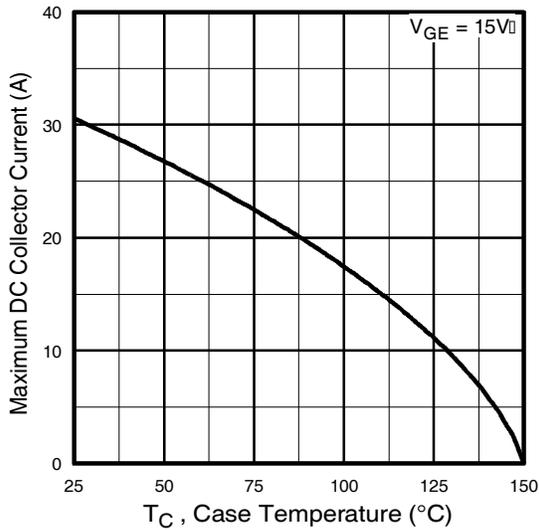


Fig. 4 - Maximum Collector Current vs. Case Temperature

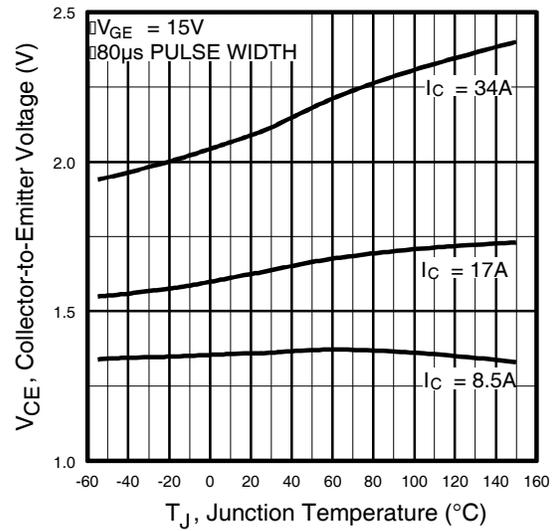


Fig. 5 - Typical Collector-to-Emitter Voltage vs. Junction Temperature

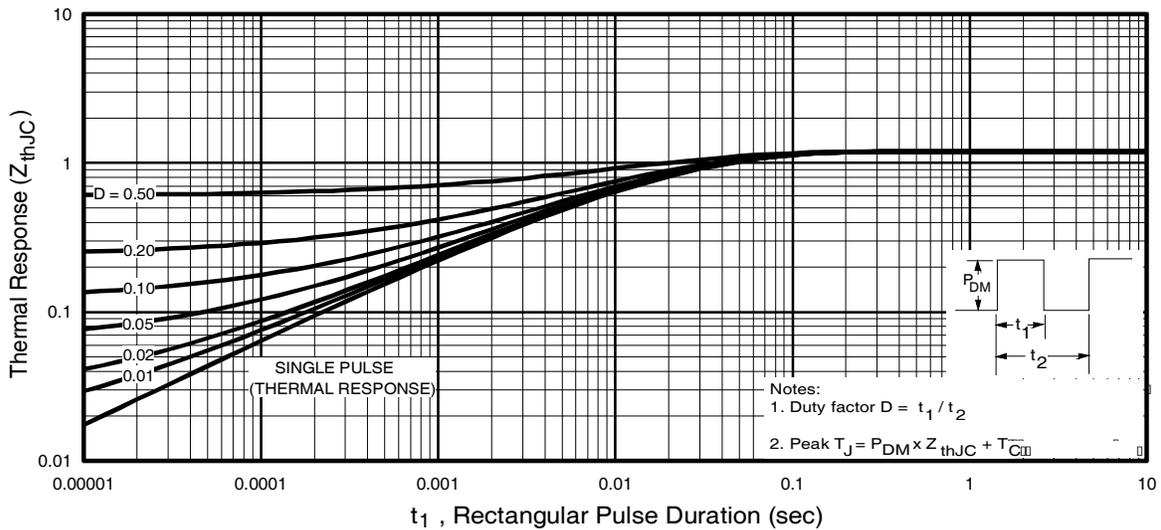


Fig. 6 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

IRG4BC30FDPbF

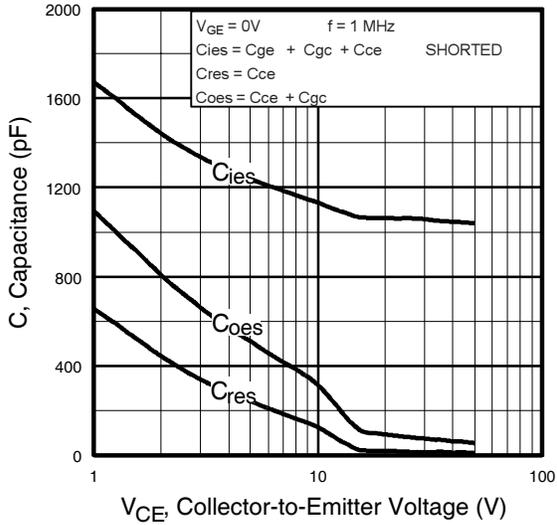


Fig. 7 - Typical Capacitance vs. Collector-to-Emitter Voltage

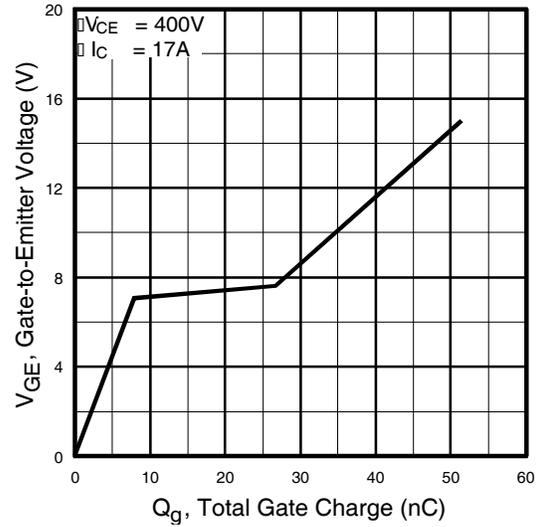


Fig. 8 - Typical Gate Charge vs. Gate-to-Emitter Voltage

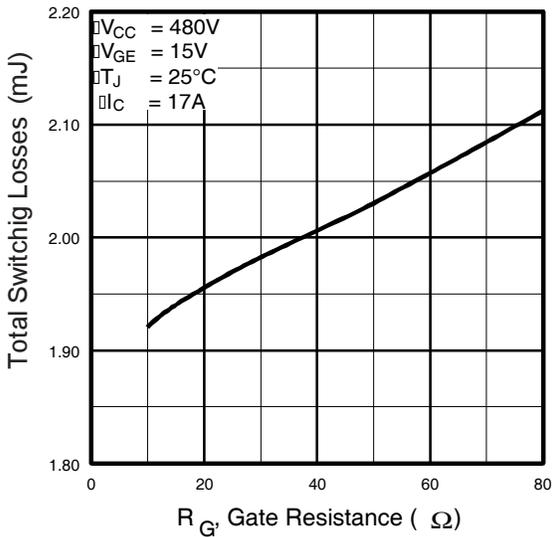


Fig. 9 - Typical Switching Losses vs. Gate Resistance

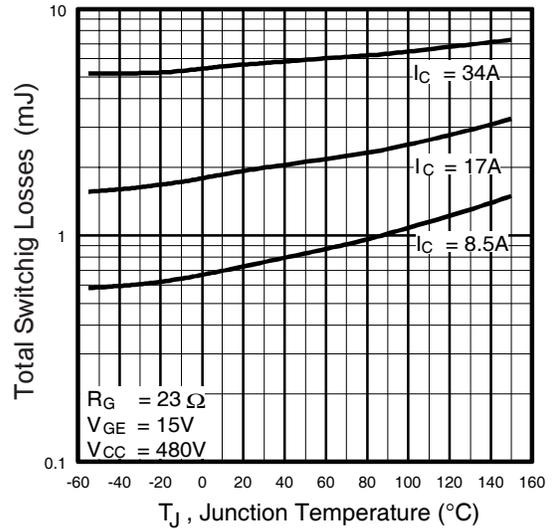


Fig. 10 - Typical Switching Losses vs. Junction Temperature

IRG4BC30FDPbF

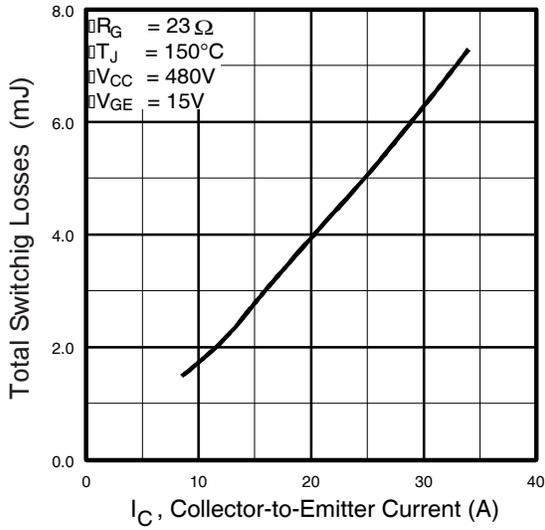


Fig. 11 - Typical Switching Losses vs. Collector-to-Emitter Current

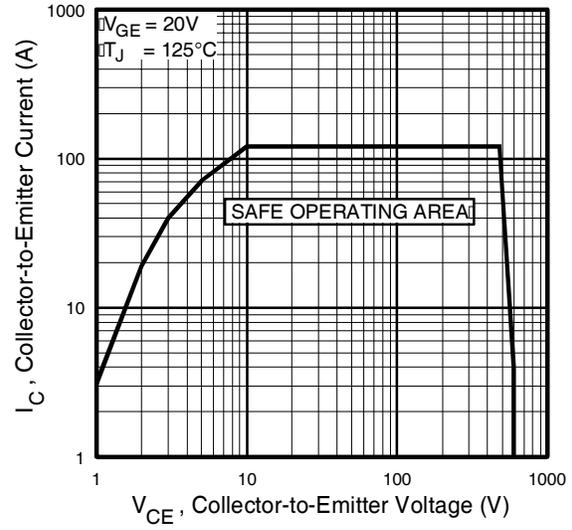


Fig. 12 - Turn-Off SOA

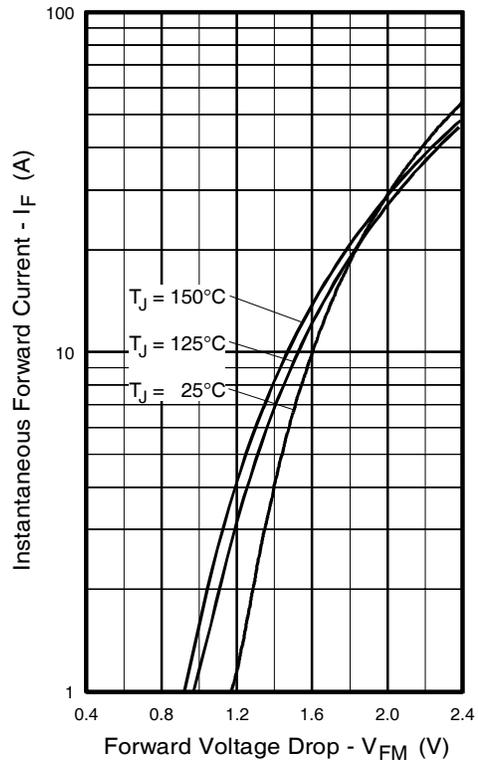


Fig. 13 - Maximum Forward Voltage Drop vs. Instantaneous Forward Current

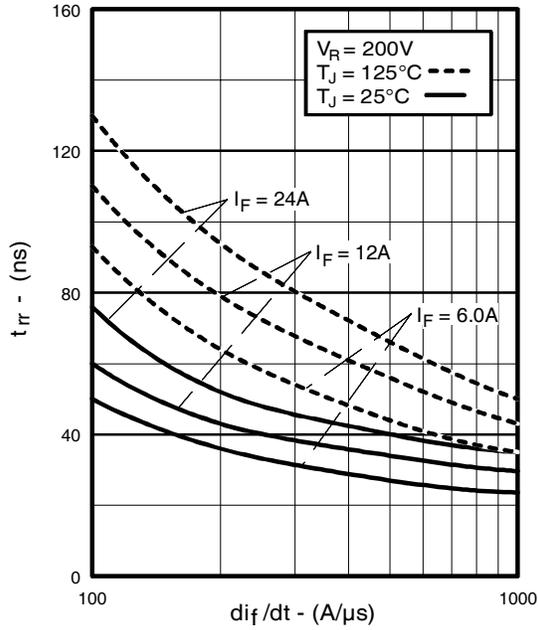


Fig. 14 - Typical Reverse Recovery vs. di_f/dt

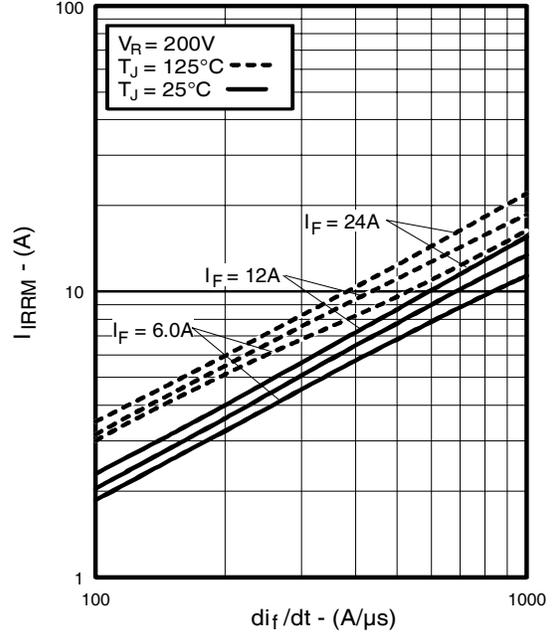


Fig. 15 - Typical Recovery Current vs. di_f/dt

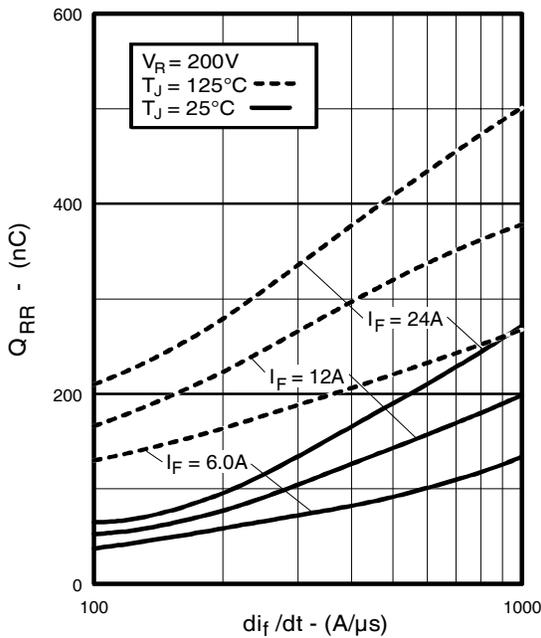


Fig. 16 - Typical Stored Charge vs. di_f/dt

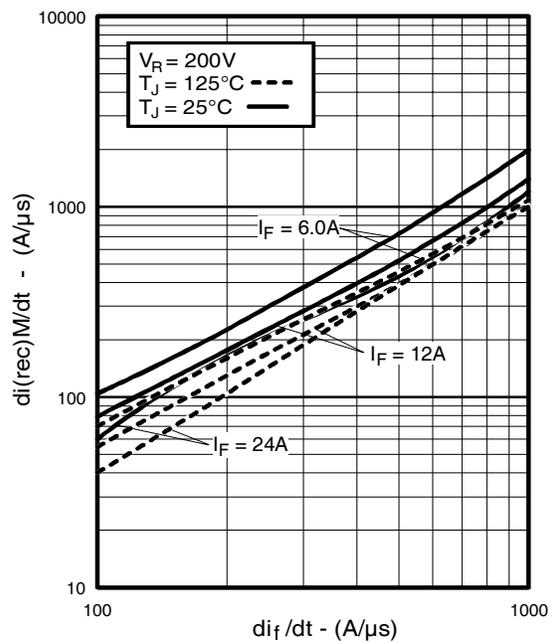


Fig. 17 - Typical $di_{(rec)M}/dt$ vs. di_f/dt

IRG4BC30FDPbF

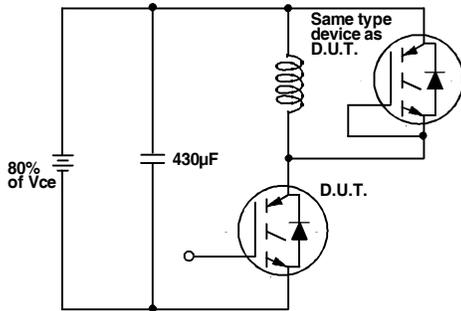


Fig. 18a - Test Circuit for Measurement of I_{LM} , E_{on} , $E_{off}(\text{diode})$, t_{rr} , Q_{rr} , I_{rr} , $t_{d(on)}$, t_r , $t_{d(off)}$, t_f

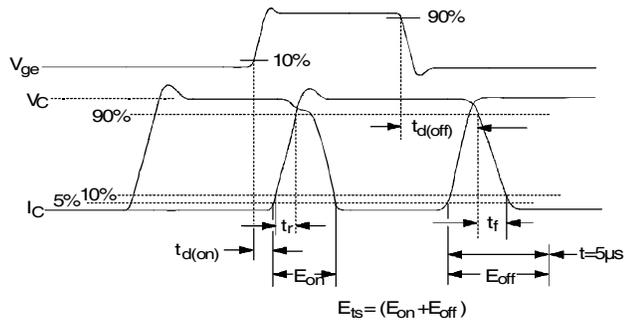


Fig. 18b - Test Waveforms for Circuit of Fig. 18a, Defining E_{off} , $t_{d(off)}$, t_f

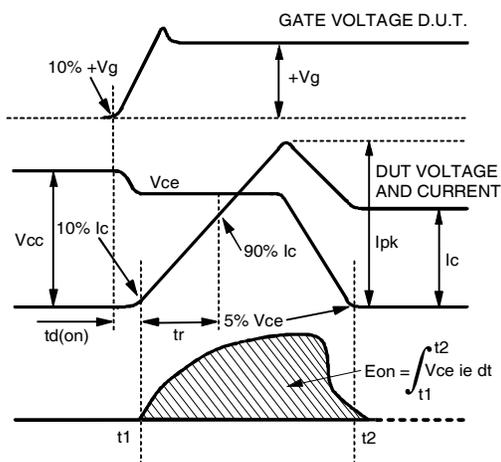


Fig. 18c - Test Waveforms for Circuit of Fig. 18a, Defining E_{on} , $t_{d(on)}$, t_r

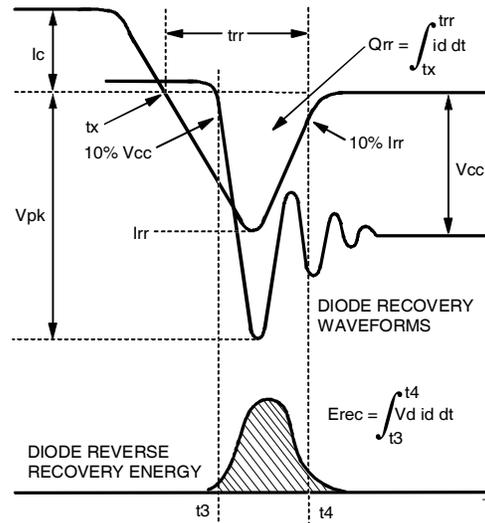


Fig. 18d - Test Waveforms for Circuit of Fig. 18a, Defining E_{rec} , t_{rr} , Q_{rr} , I_{rr}

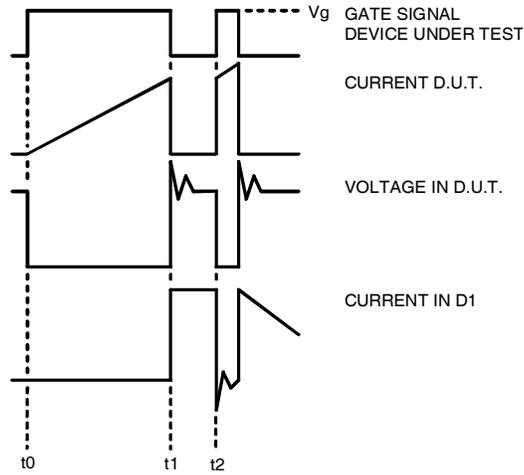


Figure 18e. Macro Waveforms for Figure 18a's Test Circuit

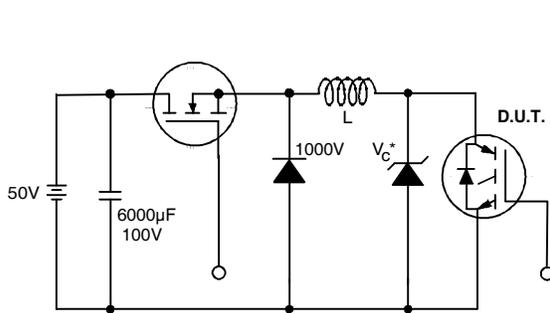
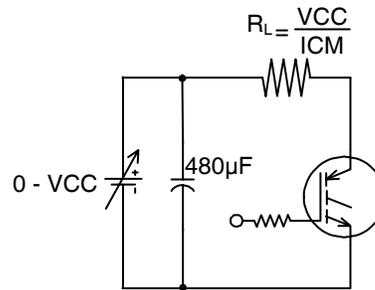


Figure 19. Clamped Inductive Load Test Circuit



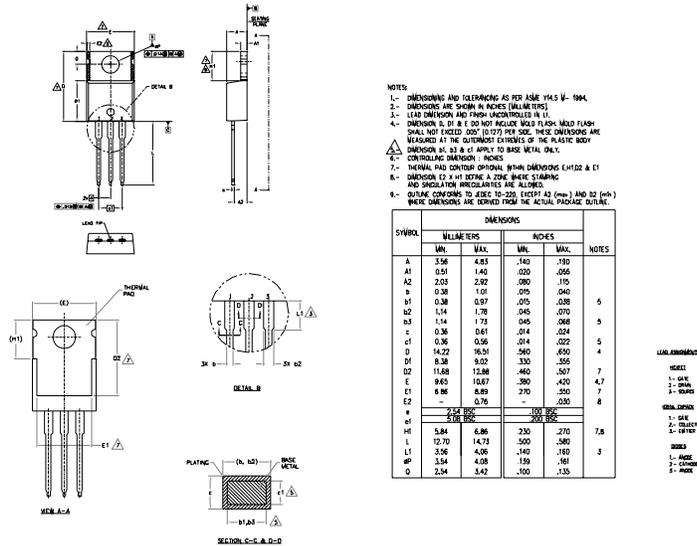
Pulsed Collector Current Test Circuit

Figure 20. Pulsed Collector Current Test Circuit

IRG4BC30FDPbF

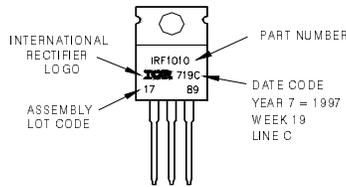
International
IR Rectifier

TO-220AB Package Outline (Dimensions are shown in millimeters (inches))



TO-220AB Part Marking Information

EXAMPLE: THIS IS AN IRF1010
LOT CODE 1789
ASSEMBLED ON WW 19, 1 1997
IN THE ASSEMBLY LINE 'C'
Note: "P" in assembly line position indicates "Lead-Free"



Note: For the most current drawing please refer to IR website at <http://www.irf.com/package/>

Notes:

- ① Repetitive rating: $V_{GE}=20V$; pulse width limited by maximum junction temperature (figure 20)
- ② $V_{CC}=80\%(V_{CES})$, $V_{GE}=20V$, $L=10\mu H$, $R_G = 23\Omega$ (figure 19)
- ③ Pulse width $\leq 80\mu s$; duty factor $\leq 0.1\%$.
- ④ Pulse width $5.0\mu s$, single shot.

Data and specifications subject to change without notice.

International
IR Rectifier

IR WORLD HEADQUARTERS: 233 Kansas St., El Segundo, California 90245, USA Tel: (310) 252-7105
TAC Fax: (310) 252-7903

Visit us at www.irf.com for sales contact information. 01/2010

www.irf.com